

<b>Notice of References Cited</b>	Application/Control No. 10/790,803	Applicant(s)/Patent Under Reexamination TANAHASHI ET AL.	
	Examiner Alain L. Bashore	Art Unit 1762	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,841,259 B1	01-2005	Takahashi et al.	428/812
	B	US-6,730,421 B1	05-2004	Kirino et al.	428/831.2
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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